

**Search Notes**

Application/Control No.

10/771,242

Examiner

B. Dell Chism

Applicant(s)/Patent under  
Reexamination

ZHELEVA ET AL.

Art Unit

1654

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN (Registry, Caplus, Biosis); WEST (514/14; text)	2/1/2006	BDC